

# WEST Search History

DATE: Monday, September 22, 2003

**Set Name Query**  
side by side

**Hit Count Set Name**  
result set

*DB=USPT,PGPB,JPAB; PLUR=YES; OP=OR*

L18	L17 not l15	70	L18
L17	l12 and (test or simulat\$ or verification)	241	L17
L16	L15 not l14	15	L16
L15	L13 and (test or simulation or verificaiton or verifying)	172	L15
L14	L13 and design	167	L14
L13	L12 and (circuit or core or module)	192	L13
L12	l11 and (mutation or probabilt\$ or genetic\$)	258	L12
L11	l9 and L10	407	L11
L10	value same parameter\$	176802	L10
L9	random\$ same combinat\$ same generat\$ same paramete\$	561	L9
L8	L7 and circuit	88	L8
L7	L6 and (test\$ or verification or simulation)	191	L7
L6	L5 and (probabilit\$ or genetic or mutation)	204	L6
L5	l3 and L4	340	L5
L4	random\$ same generat\$	79975	L4
L3	parameterized and random\$ and generat\$ and (parameter same value)	998	L3
L2	l1 and parameterized	4	L2
L1	((parameter same value same generat\$ same test ) same random\$)	119	L1

END OF SEARCH HISTORY